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This document, MC74HC4066/D has been canceled and replaced by MC74HC4066A/D

LAN was sent 9/28/01

Quad Analog Switch/ Multiplexer/Demultiplexer
## High–Performance Silicon–Gate CMOS

The MC54/74HC4066 utilizes silicon–gate CMOS technology to achieve fast propagation delays, low ON resistances, and low OFF–channel leakage current. This bilateral switch/multiplexer/demultiplexer controls analog and digital voltages that may vary across the full power–supply range (from V_{CC} to GND).

The HC4066 is identical in pinout to the metal–gate CMOS MC14016 and MC14066. Each device has four independent switches. The device has been designed so that the ON resistances (R_{ON}) are much more linear over input voltage than R_{ON} of metal–gate CMOS analog switches.

This device is identical in both function and pinout to the HC4016. The ON/OFF control inputs are compatible with standard CMOS outputs; with pullup resistors, they are compatible with LSTTL outputs. For analog switches with voltage–level translators, see the HC4316.

- Fast Switching and Propagation Speeds
- High ON/OFF Output Voltage Ratio
- Low Crosstalk Between Switches
- Diode Protection on All Inputs/Outputs
- Wide Power–Supply Voltage Range (V_{CC} – GND) = 2.0 to 12.0 Volts
- Analog Input Voltage Range (V_{CC} – GND) = 2.0 to 12.0 Volts
- Improved Linearity and Lower ON Resistance over Input Voltage than the MC14016 or MC14066 or HC4016
- Low Noise
- Chip Complexity: 44 FETs or 11 Equivalent Gates
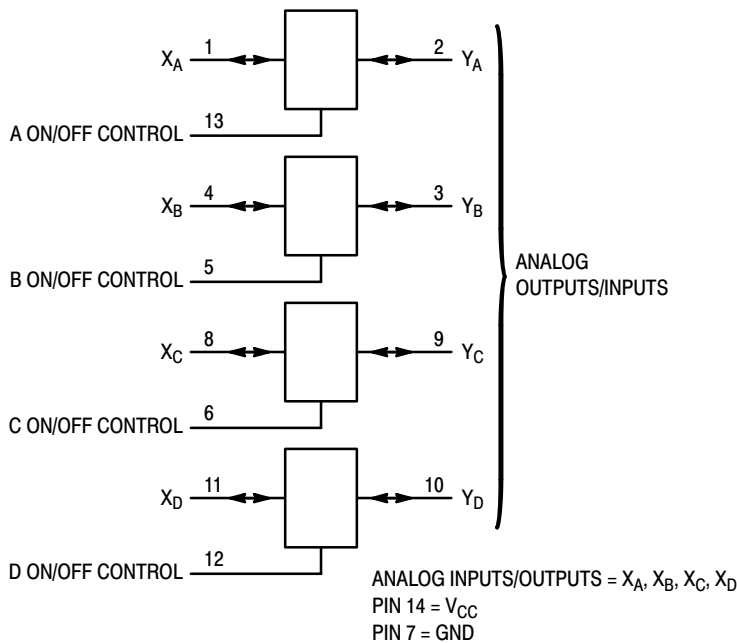
MC54/74HC4066
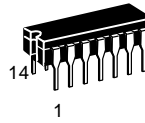
J SUFFIX
CERAMIC PACKAGE
CASE 632–08
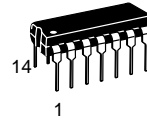
N SUFFIX
PLASTIC PACKAGE
CASE 646–06

D SUFFIX
SOIC PACKAGE
CASE 751A–03

DT SUFFIX
TSSOP PACKAGE
CASE 948G–01

ORDERING INFORMATION

MC54HCXXXXJ	Ceramic
MC74HCXXXXN	Plastic
MC74HCXXXXD	SOIC
MC74HCXXXXDT	TSSOP

LOGIC DIAGRAM

ANALOG OUTPUTS/INPUTS

ANALOG INPUTS/OUTPUTS = X_A, X_B, X_C, X_D
PIN 14 = V_{CC}
PIN 7 = GND

PIN ASSIGNMENT

X_A	1	14	V_{CC}
Y_A	2	13	A ON/OFF CONTROL
Y_B	3	12	D ON/OFF CONTROL
X_B	4	11	X_D
B ON/OFF CONTROL	5	10	Y_D
C ON/OFF CONTROL	6	9	Y_C
GND	7	8	X_C
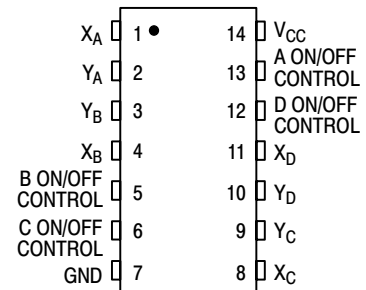
FUNCTION TABLE

On/Off Control Input	State of Analog Switch
L	Off
H	On

MAXIMUM RATINGS*

Symbol	Parameter	Value	Unit
V_{CC}	Positive DC Supply Voltage (Referenced to GND)	− 0.5 to + 14.0	V
V_{IS}	Analog Input Voltage (Referenced to GND)	− 0.5 to V_{CC} + 0.5	V
V_{in}	Digital Input Voltage (Referenced to GND)	− 1.5 to V_{CC} + 1.5	V
I	DC Current Into or Out of Any Pin	± 25	mA
P_D	Power Dissipation in Still Air, Plastic or Ceramic DIP† SOIC Package† TSSOP Package†	750 500 450	mW
T_{stg}	Storage Temperature	− 65 to + 150	°C
T_L	Lead Temperature, 1 mm from Case for 10 Seconds (Plastic DIP, SOIC or TSSOP Package) (Ceramic DIP)	 260 300	°C

* Maximum Ratings are those values beyond which damage to the device may occur.
 Functional operation should be restricted to the Recommended Operating Conditions.
†Derating — Plastic DIP: − 10 mW/°C from 65° to 125°C
       Ceramic DIP: − 10 mW/°C from 100° to 125°C
       SOIC Package: − 7 mW/°C from 65° to 125°C
       TSSOP Package: − 6.1 mW/°C from 65° to 125°C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high–impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range GND $\le$ (V_{in} or V_{out}) $\le$ V_{CC}.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or V_{CC}). Unused outputs must be left open. I/O pins must be connected to a properly terminated line or bus.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V_{CC}	Positive DC Supply Voltage (Referenced to GND)	2.0	12.0	V
V_{IS}	Analog Input Voltage (Referenced to GND)	GND	V_{CC}	V
V_{in}	Digital Input Voltage (Referenced to GND)	GND	V_{CC}	V
V_{IO}*	Static or Dynamic Voltage Across Switch	—	1.2	V
T_A	Operating Temperature, All Package Types	− 55	+ 125	°C
t_r, t_f	Input Rise and Fall Time, ON/OFF Control Inputs (Figure 10) V_{CC} = 2.0 V V_{CC} = 4.5 V V_{CC} = 9.0 V V_{CC} = 12.0 V	0 0 0 0	1000 500 400 250	ns

* For voltage drops across the switch greater than 1.2 V (switch on), excessive V_{CC} current may
 be drawn; i.e., the current out of the switch may contain both V_{CC} and switch input components.
 The reliability of the device will be unaffected unless the Maximum Ratings are exceeded.

DC ELECTRICAL CHARACTERISTIC Digital Section (Voltages Referenced to GND)

Symbol	Parameter	Test Conditions	V_{CC} V	Guaranteed Limit			Unit
				− 55 to 25°C	$\le$ 85°C	$\le$ 125°C	
V_{IH}	Minimum High–Level Voltage ON/OFF Control Inputs	R_{on} = Per Spec	2.0 4.5 9.0 12.0	1.5 3.15 6.3 8.4	1.5 3.15 6.3 8.4	1.5 3.15 6.3 8.4	V
V_{IL}	Maximum Low–Level Voltage ON/OFF Control Inputs	R_{on} = Per Spec	2.0 4.5 9.0 12.0	0.3 0.9 1.8 2.4	0.3 0.9 1.8 2.4	0.3 0.9 1.8 2.4	V
I_{in}	Maximum Input Leakage Current ON/OFF Control Inputs	V_{in} = V_{CC} or GND	12.0	± 0.1	± 1.0	± 1.0	μA
I_{CC}	Maximum Quiescent Supply Current (per Package)	V_{in} = V_{CC} or GND V_{IO} = 0 V	6.0 12.0	2 8	20 80	40 160	μA

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DC ELECTRICAL CHARACTERISTICS Analog Section (Voltages Referenced to GND)

Symbol	Parameter	Test Conditions	V_{CC} V	Guaranteed Limit			Unit
				− 55 to 25°C	≤ 85°C	≤ 125°C	
R_{on}	Maximum "ON" Resistance	$V_{in} = V_{IH}$ $V_{IS} = V_{CC}$ to GND $I_S \leq 2.0$ mA (Figures 1, 2)	2.0† 4.5 9.0 12.0	— 170 85 85	— 215 106 106	— 255 130 130	Ω
		$V_{in} = V_{IH}$ $V_{IS} = V_{CC}$ or GND (Endpoints) $I_S \leq 2.0$ mA (Figures 1, 2)	2.0 4.5 9.0 12.0	— 85 63 63	— 106 78 78	— 130 95 95	
ΔR_{on}	Maximum Difference in "ON" Resistance Between Any Two Channels in the Same Package	$V_{in} = V_{IH}$ $V_{IS} = 1/2 \ (V_{CC} - GND)$ $I_S \leq 2.0$ mA	2.0 4.5 9.0 12.0	— 30 20 20	— 35 25 25	— 40 30 30	Ω
I_{off}	Maximum Off–Channel Leakage Current, Any One Channel	$V_{in} = V_{IL}$ $V_{IO} = V_{CC}$ or GND Switch Off (Figure 3)	12.0	0.1	0.5	1.0	μA
I_{on}	Maximum On–Channel Leakage Current, Any One Channel	$V_{in} = V_{IH}$ $V_{IS} = V_{CC}$ or GND (Figure 4)	12.0	0.1	0.5	1.0	μA

†At supply voltage (V_{CC} – GND) approaching 2 V the analog switch–on resistance becomes extremely non–linear. Therefore, for low–voltage operation, it is recommended that these devices only be used to control digital signals.

AC ELECTRICAL CHARACTERISTICS (C_L = 50 pF, ON/OFF Control Inputs: $t_r = t_f = 6$ ns)

Symbol	Parameter	V_{CC} V	Guaranteed Limit			Unit
			− 55 to 25°C	≤ 85°C	≤ 125°C	
t_{PLH}, t_{PHL}	Maximum Propagation Delay, Analog Input to Analog Output (Figures 8 and 9)	2.0 4.5 9.0 12.0	50 10 10 10	65 13 13 13	75 15 15 15	ns
t_{PLZ}, t_{PHZ}	Maximum Propagation Delay, ON/OFF Control to Analog Output (Figures 10 and 11)	2.0 4.5 9.0 12.0	150 30 30 30	190 38 30 30	225 45 30 30	ns
t_{PZL}, t_{PZH}	Maximum Propagation Delay, ON/OFF Control to Analog Output (Figures 10 and 1 1)	2.0 4.5 9.0 12.0	125 25 25 25	160 32 32 32	185 37 37 37	ns
C	Maximum Capacitance ON/OFF Control Input	—	10	10	10	pF
	Control Input = GND Analog I/O Feedthrough	— —	35 1.0	35 1.0	35 1.0	

		Typical @ 25°C, V_{CC} = 5.0 V	
C_{PD}	Power Dissipation Capacitance (Per Switch) (Figure 13)*	15	pF

ADDITIONAL APPLICATION CHARACTERISTICS (Voltages Referenced to GND Unless Noted)

Symbol	Parameter	Test Conditions	V_{CC} V	Limit* 25°C 54/74HC	Unit
BW	Maximum On–Channel Bandwidth or Minimum Frequency Response (Figure 5)	f_{in} = 1 MHz Sine Wave Adjust f_{in} Voltage to Obtain 0 dBm at V_{OS} Increase f_{in} Frequency Until dB Meter Reads – 3 dB R_L = 50 Ω, C_L = 10 pF	4.5 9.0 12.0	150 160 160	MHz
—	Off–Channel Feedthrough Isolation (Figure 6)	f_{in} ≡ Sine Wave Adjust f_{in} Voltage to Obtain 0 dBm at V_{IS} f_{in} = 10 kHz, R_L = 600 Ω, C_L = 50 pF	4.5 9.0 12.0	– 50 – 50 – 50	dB
		f_{in} = 1.0 MHz, R_L = 50 Ω, C_L = 10 pF	4.5 9.0 12.0	– 40 – 40 – 40	
—	Feedthrough Noise, Control to Switch (Figure 7)	V_{in} ≤ 1 MHz Square Wave (t_r = t_f = 6 ns) Adjust R_L at Setup so that I_S = 0 A R_L = 600 Ω, C_L = 50 pF	4.5 9.0 12.0	60 130 200	mV$_{PP}$
		R_L = 10 kΩ, C_L = 10 pF	4.5 9.0 12.0	30 65 100	
—	Crosstalk Between Any Two Switches (Figure 12)	f_{in} ≡ Sine Wave Adjust f_{in} Voltage to Obtain 0 dBm at V_{IS} f_{in} = 10 kHz, R_L = 600 Ω, C_L = 50 pF	4.5 9.0 12.0	– 70 – 70 – 70	dB
		f_{in} = 1.0 MHz, R_L = 50 Ω, C_L = 10 pF	4.5 9.0 12.0	– 80 – 80 – 80	
THD	Total Harmonic Distortion (Figure 14)	f_{in} = 1 kHz, R_L = 10 kΩ, C_L = 50 pF THD = THD$_{Measured}$ – THD$_{Source}$ V_{IS} = 4.0 V$_{PP}$ sine wave V_{IS} = 8.0 V$_{PP}$ sine wave V_{IS} = 11.0 V$_{PP}$ sine wave	 4.5 9.0 12.0	 0.10 0.06 0.04	%

* Guaranteed limits not tested. Determined by design and verified by qualification.

MC54/74HC4066
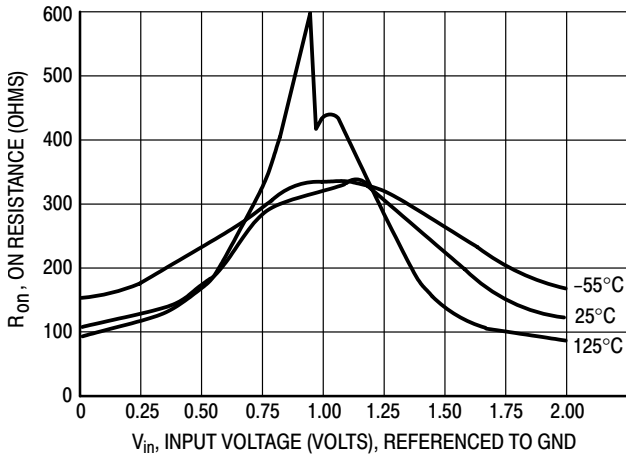
Figure 1a. Typical On Resistance, V_{CC} = 2.0 V
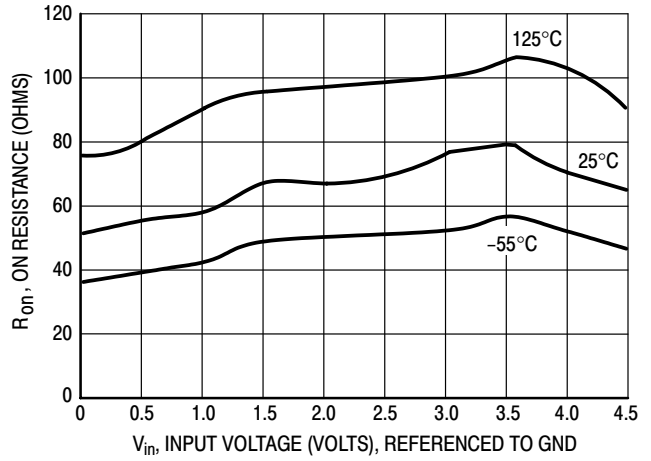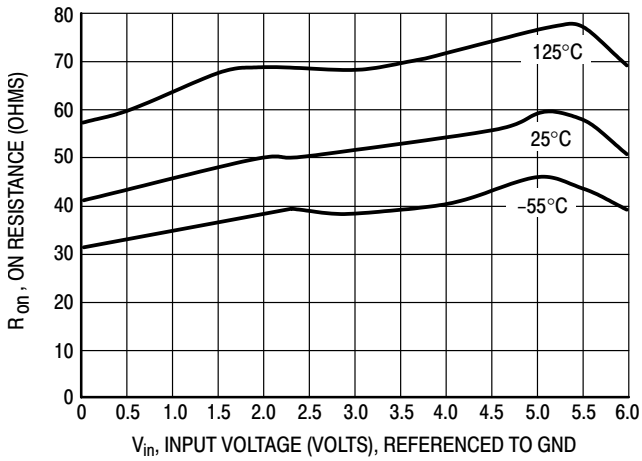

Figure 1b. Typical On Resistance, V_{CC} = 4.5 V

Figure 1c. Typical On Resistance, V_{CC} = 6.0 V

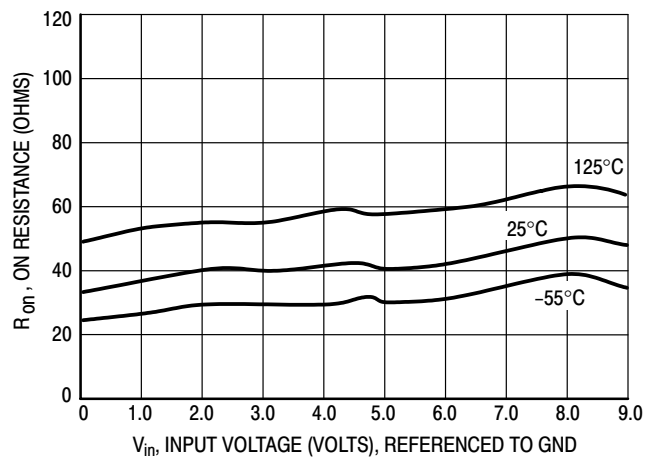

Figure 1d. Typical On Resistance, V_{CC} = 9.0 V
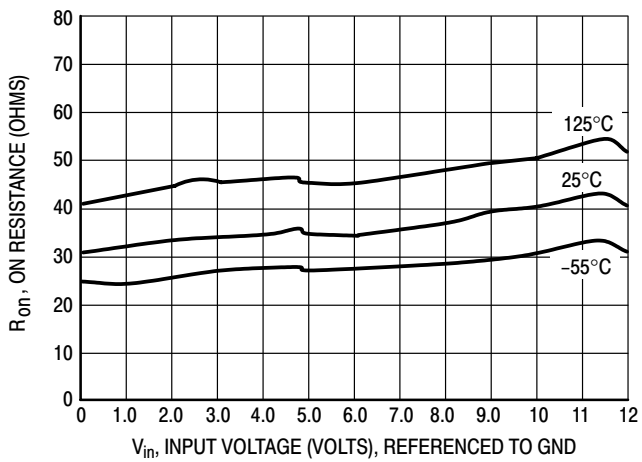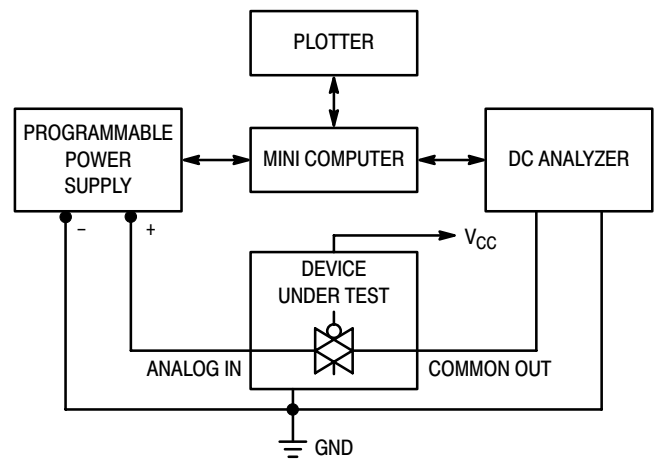

Figure 1e. Typical On Resistance, V_{CC} = 12 V
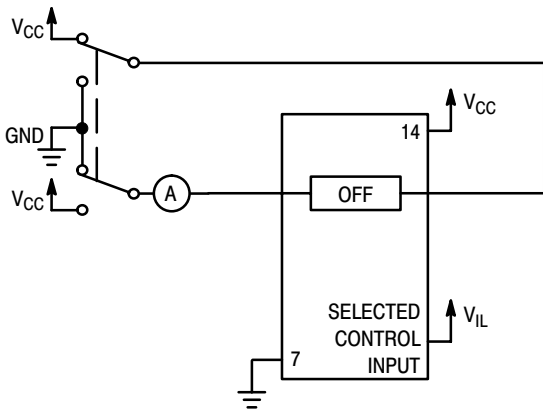

Figure 2. On Resistance Test Set–Up

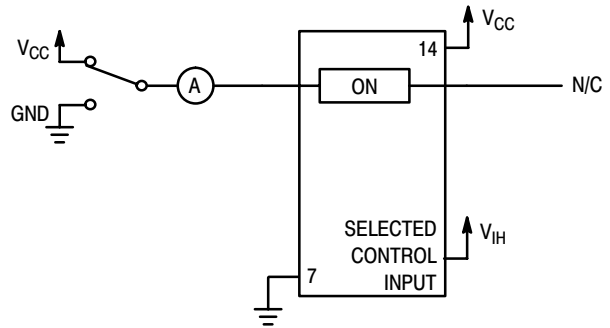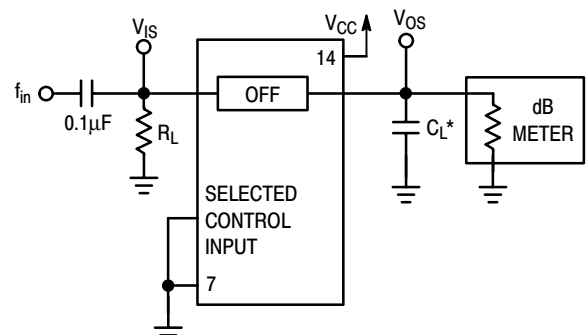**Figure 3. Maximum Off Channel Leakage Current, Any One Channel, Test Set–Up**

Figure 4. Maximum On Channel Leakage Current, Test Set–Up
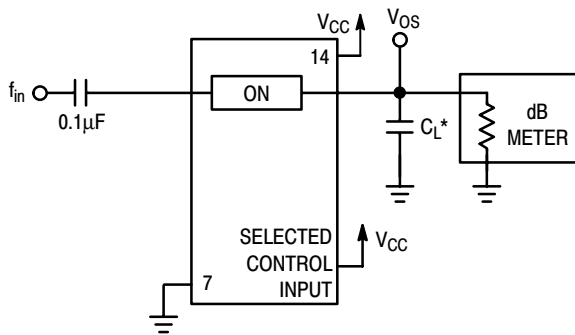
*Includes all probe and jig capacitance.

Figure 5. Maximum On–Channel Bandwidth Test Set–Up

*Includes all probe and jig capacitance.

Figure 6. Off–Channel Feedthrough Isolation, Test Set–Up
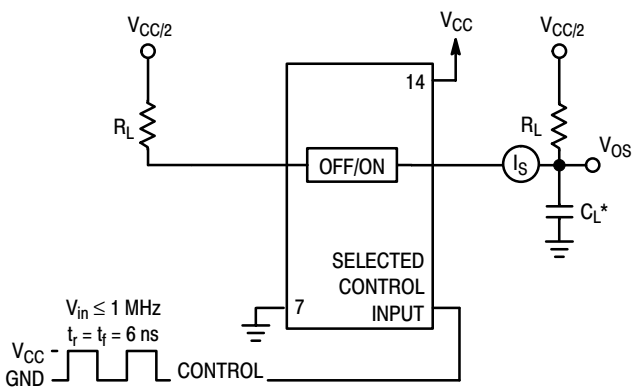
*Includes all probe and jig capacitance.

Figure 7. Feedthrough Noise, ON/OFF Control to Analog Out, Test Set–Up
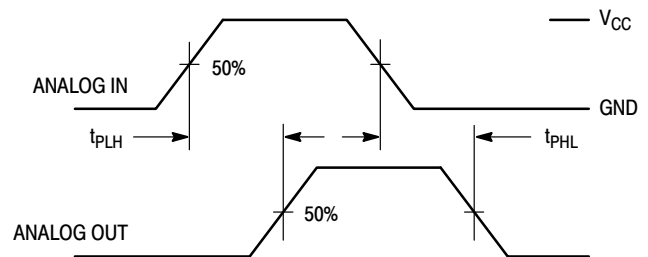
Figure 8. Propagation Delays, Analog In to Analog Out

MC54/74HC4066
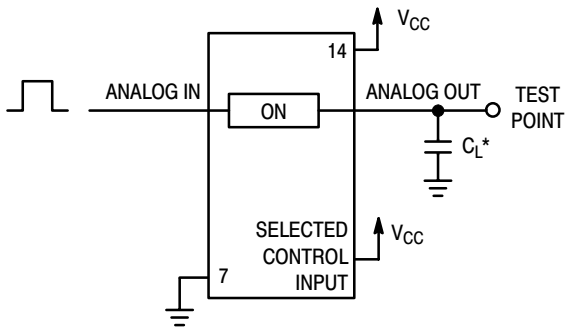
*Includes all probe and jig capacitance.
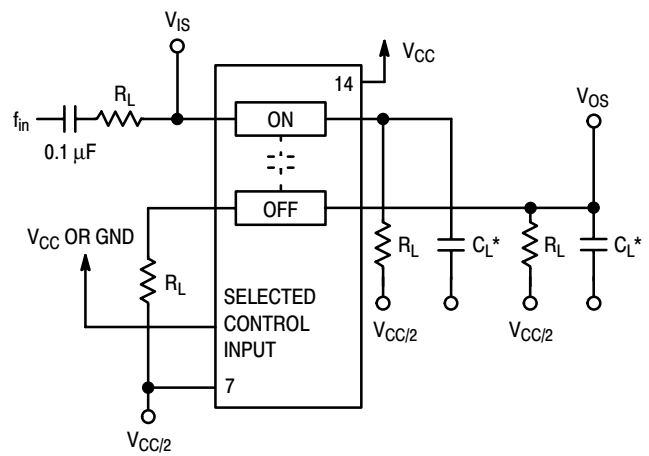
Figure 9. Propagation Delay Test Set–Up
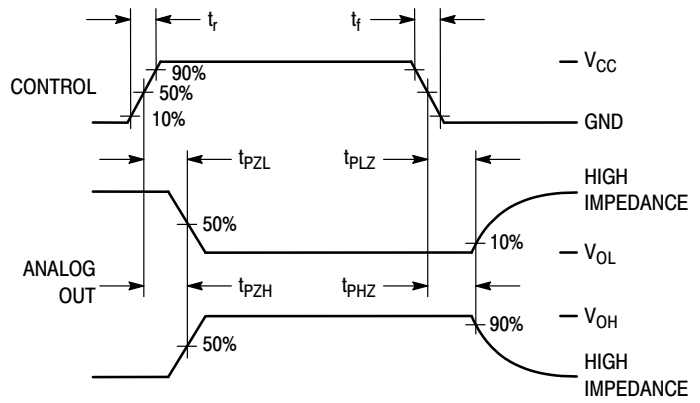
Figure 10. Propagation Delay, ON/OFF Control to Analog Out

POSITION ① WHEN TESTING t_{PHZ} AND t_{PZH}
POSITION ② WHEN TESTING t_{PLZ} AND t_{PZL}
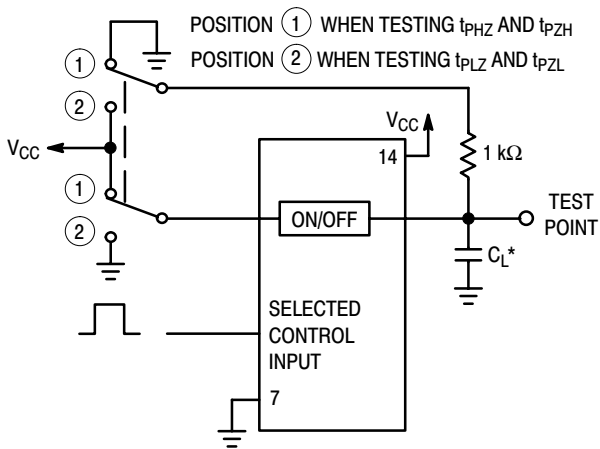
*Includes all probe and jig capacitance.

Figure 11. Propagation Delay Test Set–Up

*Includes all probe and jig capacitance.
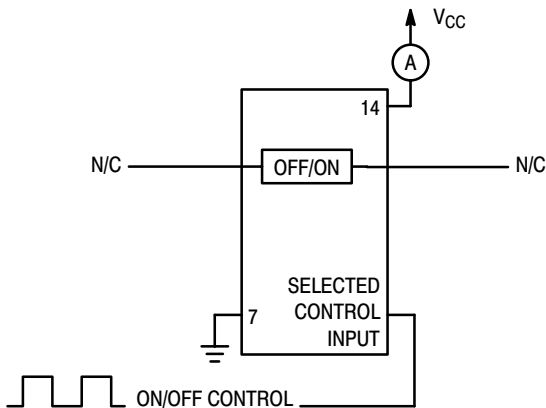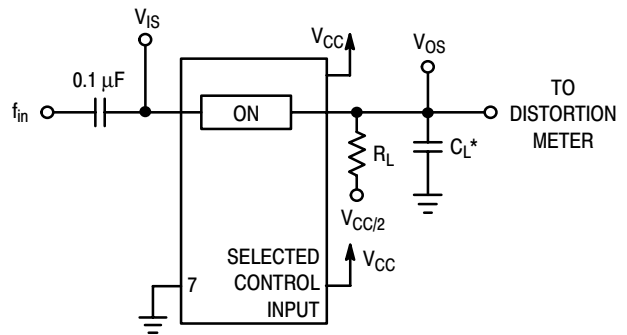
Figure 12. Crosstalk Between Any Two Switches, Test Set–Up

Figure 13. Power Dissipation Capacitance Test Set–Up

*Includes all probe and jig capacitance.

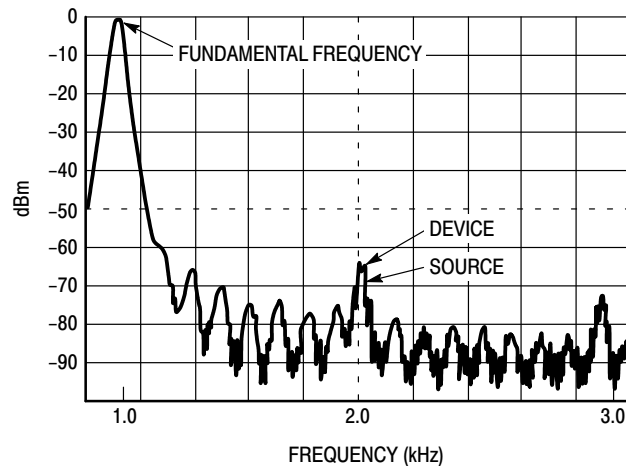**Figure 14. Total Harmonic Distortion, Test Set–Up**

Figure 15. Plot, Harmonic Distortion

APPLICATION INFORMATION

The ON/OFF Control pins should be at V_{CC} or GND logic levels, V_{CC} being recognized as logic high and GND being recognized as a logic low. Unused analog inputs/outputs may be left floating (not connected). However, it is advisable to tie unused analog inputs and outputs to V_{CC} or GND through a low value resistor. This minimizes crosstalk and feedthrough noise that may be picked–up by the unused I/O pins.

The maximum analog voltage swings are determined by the supply voltages V_{CC} and GND. The positive peak analog voltage should not exceed V_{CC}. Similarly, the negative peak analog voltage should not go below GND. In the example
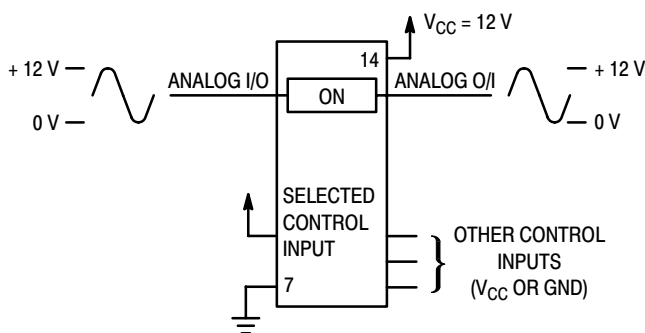
below, the difference between V_{CC} and GND is twelve volts. Therefore, using the configuration in Figure 16, a maximum analog signal of twelve volts peak–to–peak can be controlled.

When voltage transients above V_{CC} and/or below GND are anticipated on the analog channels, external diodes (Dx) are recommended as shown in Figure 17. These diodes should be small signal, fast turn–on types able to absorb the maximum anticipated current surges during clipping. An alternate method would be to replace the Dx diodes with MO•sorbs (high current surge protectors). MO•sorbs are fast turn–on devices ideally suited for precise DC protection with no inherent wear out mechanism.
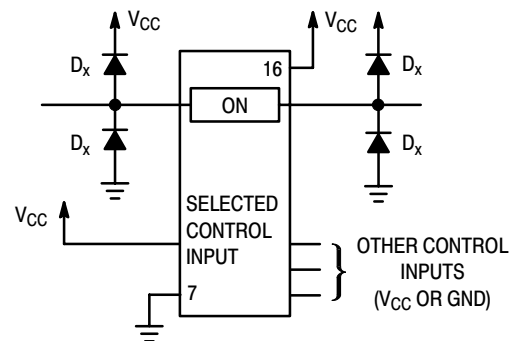

Figure 16. 12 V Application

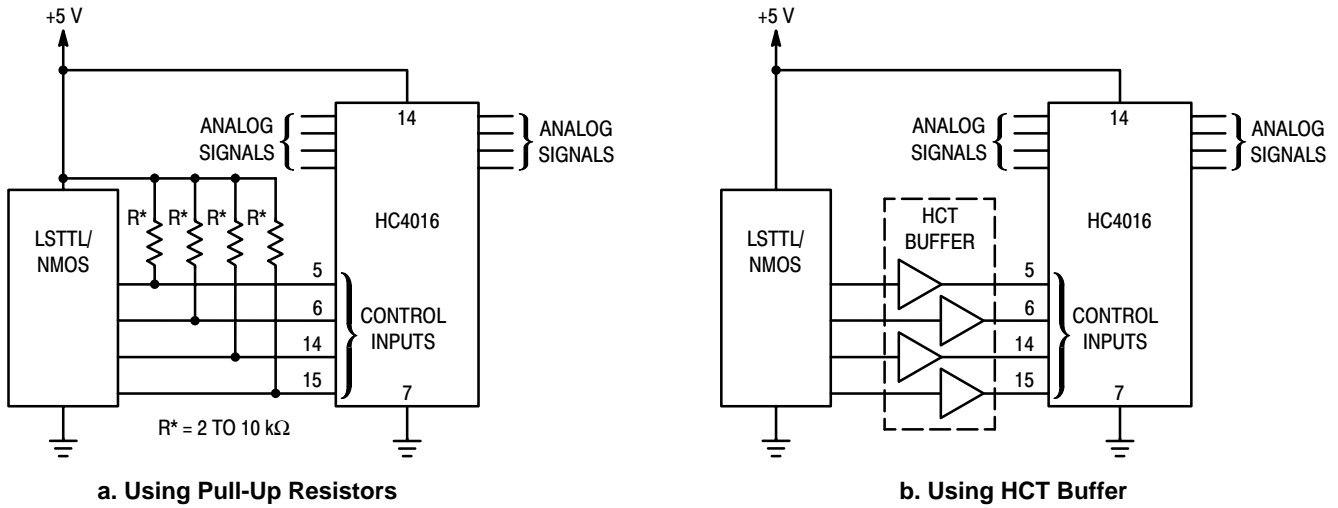**Figure 17. Transient Suppressor Application**

MC54/74HC4066

a. Using Pull-Up Resistors

R* = 2 TO 10 kΩ

b. Using HCT Buffer
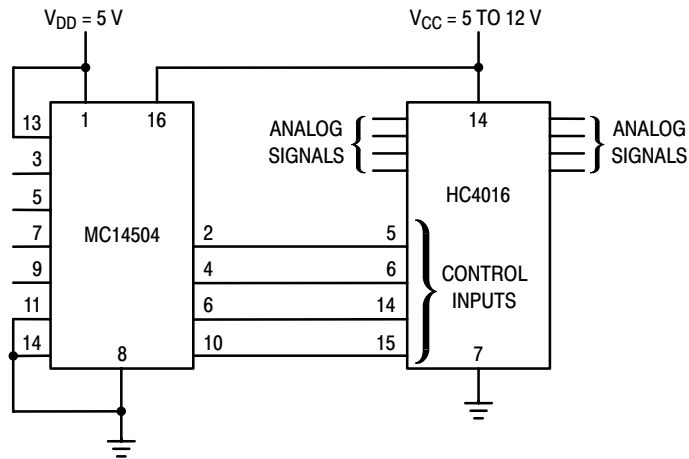
Figure 18. LSTTL/NMOS to HCMOS Interface

Figure 19. TTL/NMOS–to–CMOS Level Converter
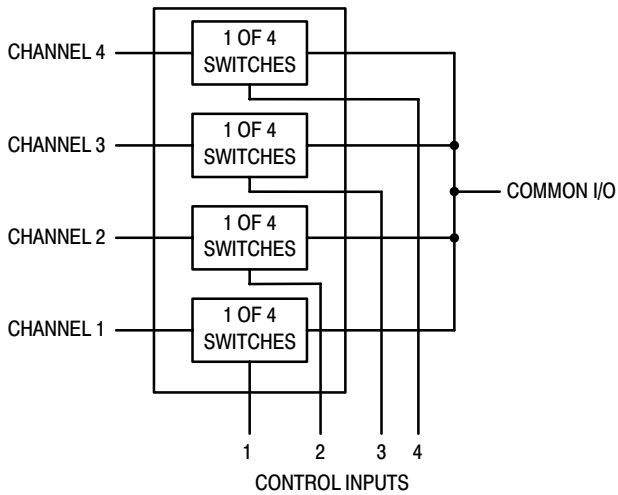**Analog Signal Peak–to–Peak Greater than 5 V**
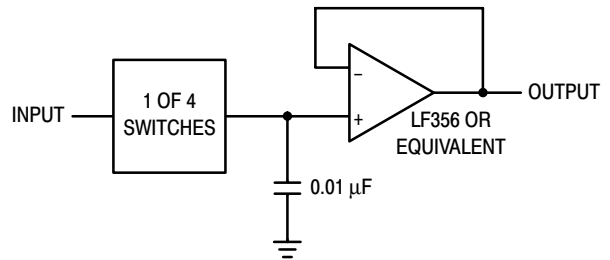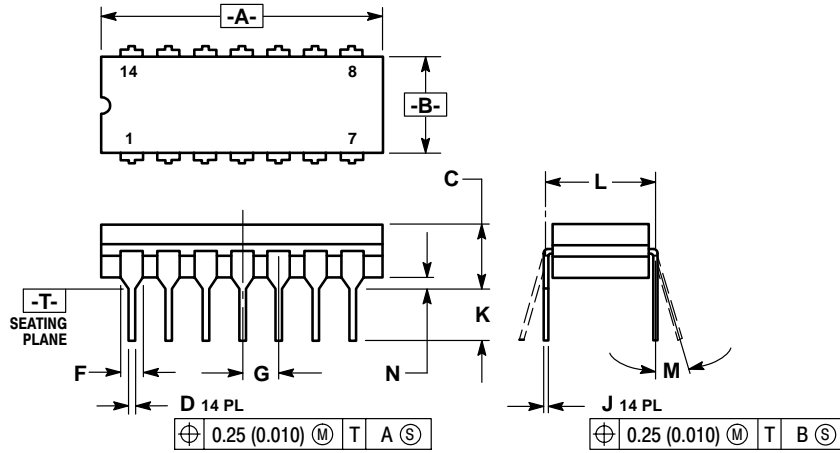**(Also see HC4316)**

Figure 20. 4–Input Multiplexer

**Figure 21. Sample/Hold Amplifier**

OUTLINE DIMENSIONS

J SUFFIX
CERAMIC DIP PACKAGE
CASE 632–08
ISSUE Y

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEAD WHEN FORMED PARALLEL.
4. DIMESNION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

| DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.750	0.785	19.05	19.94
B	0.245	0.280	6.23	7.11
C	0.155	0.200	3.94	5.08
D	0.015	0.020	0.39	0.50
F	0.055	0.065	1.40	1.65
G	0.100 BSC		2.54 BSC	
J	0.008	0.015	0.21	0.38
K	0.125	0.170	3.18	4.31
L	0.300 BSC		7.62 BSC	
M	0°	15°	0°	15°
N	0.020	0.040	0.51	1.01

N SUFFIX
PLASTIC DIP PACKAGE
CASE 646–06
ISSUE L
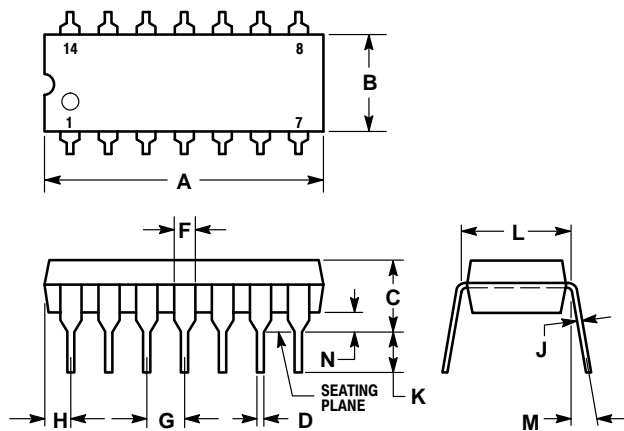
NOTES:
1. LEADS WITHIN 0.13 (0.005) RADIUS OF TRUE POSITION AT SEATING PLANE AT MAXIMUM MATERIAL CONDITION.
2. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
3. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
4. ROUNDED CORNERS OPTIONAL.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.715	0.770	18.16	19.56
B	0.240	0.260	6.10	6.60
C	0.145	0.185	3.69	4.69
D	0.015	0.021	0.38	0.53
F	0.040	0.070	1.02	1.78
G	0.100 BSC		2.54 BSC	
H	0.052	0.095	1.32	2.41
J	0.008	0.015	0.20	0.38
K	0.115	0.135	2.92	3.43
L	0.300 BSC		7.62 BSC	
M	0°	10°	0°	10°
N	0.015	0.039	0.39	1.01

MC54/74HC4066

OUTLINE DIMENSIONS

D SUFFIX
PLASTIC SOIC PACKAGE
CASE 751A–03
ISSUE F
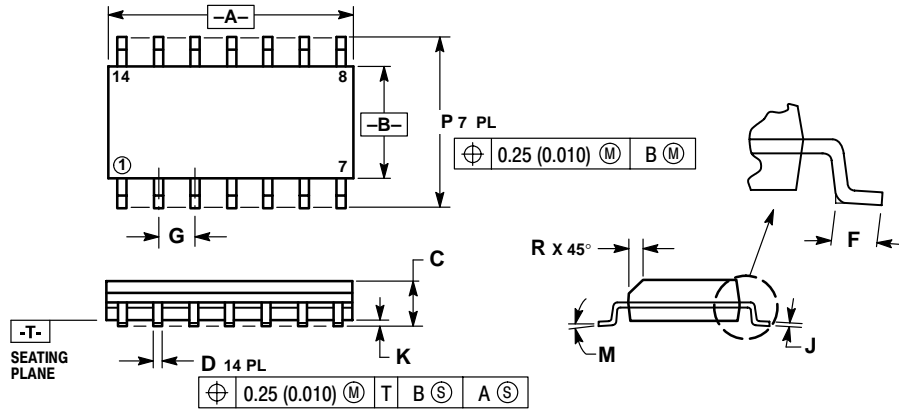
0.25 (0.010) Ⓜ B Ⓜ

0.25 (0.010) Ⓜ T B Ⓢ A Ⓢ

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	8.55	8.75	0.337	0.344
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.27 BSC		0.050 BSC	
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0°	7°	0°	7°
P	5.80	6.20	0.228	0.244
R	0.25	0.50	0.010	0.019

DT SUFFIX
PLASTIC TSSOP PACKAGE
CASE 948G–01
ISSUE O
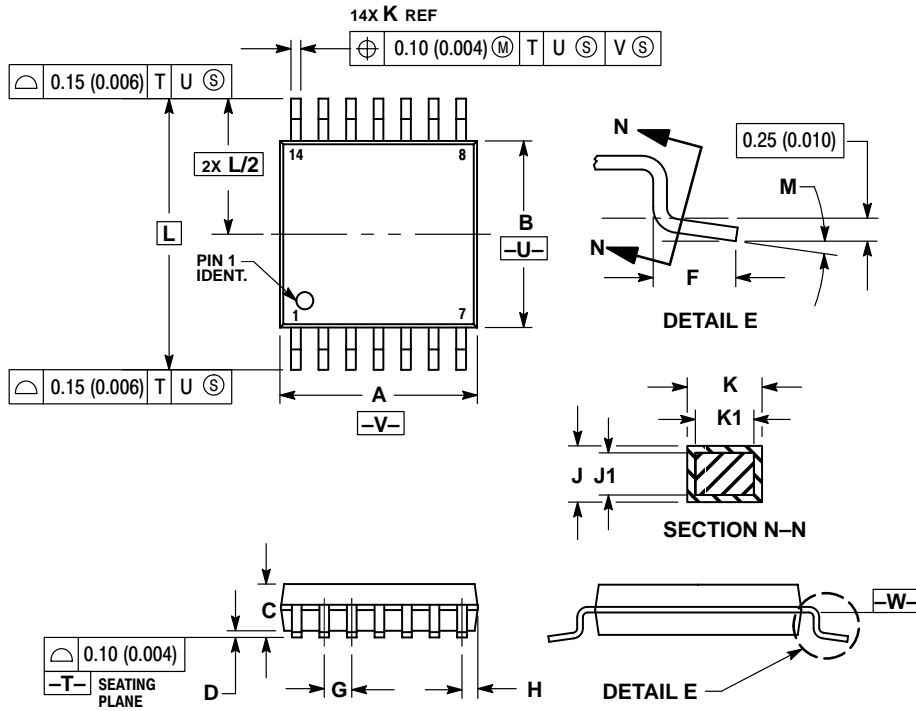
14X K REF

0.10 (0.004) Ⓜ T U Ⓢ V Ⓢ

0.15 (0.006) T U Ⓢ

0.25 (0.010)

DETAIL E

SECTION N–N

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE –W–.

0.10 (0.004)

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.90	5.10	0.193	0.200
B	4.30	4.50	0.169	0.177
C	---	1.20	---	0.047
D	0.05	0.15	0.002	0.006
F	0.50	0.75	0.020	0.030
G	0.65 BSC		0.026 BSC	
H	0.50	0.60	0.020	0.024
J	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
K	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
L	6.40 BSC		0.252 BSC	
M	0°	8°	0°	8°

PUBLICATION ORDERING INFORMATION

MC74HC4066/D